

Search Notes

Application/Control No.

10/511,138

Examiner

John K. Ford

Applicant(s)/Patent under
Reexamination

FUJITA ET AL.

Art Unit

3744

SEARCHED

Class	Subclass	Date	Examiner
165	41	11/07	<i>(initials)</i>
165	51		
123	41,49		
60	599		
123	41,31		
123	41,33		
123	196AB		
123	563		
62	244		
165	77	11/07	<i>(initials)</i>

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner